

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/668,071	FUJIWARA ET AL.	
	Examiner Hau H Nguyen	Art Unit 2674	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5654756	08-1997	Takahashi et al.	348
	C	US-5880704	03-1999	Takezaki	345
	D	US-4641157	02-1987	Aoi	346
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	M	US-			

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Applicant(s)/Patent Under

Reexamination

FUJIWARA ET AL.

Examiner

Hau H Nguyen

Art Unit

2674

Page 1 of 1

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